

# NVBLS0D5N04M8

## MOSFET – Power, Single, N-Channel

**40 V, 300 A, 0.57 mΩ**

### Features

- Typical  $R_{DS(on)}$  = 0.46 mΩ at  $V_{GS} = 10$  V,  $I_D = 80$  A
- Typical  $Q_{g(tot)}$  = 220 nC at  $V_{GS} = 10$  V,  $I_D = 80$  A
- UIS Capability
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

### MAXIMUM RATINGS $T_J = 25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Ratings	Units
Drain-to-Source Voltage	$V_{DSS}$	40	V
Gate-to-Source Voltage	$V_{GS}$	$\pm 20$	V
Drain Current – Continuous ( $V_{GS} = 10$ ) (Note 1)	$I_D$	300	A
Pulsed Drain Current $T_C = 25^\circ\text{C}$		See Figure 4	
Single Pulse Avalanche Energy (Note 2)	$E_{AS}$	1064	mJ
Power Dissipation	$P_D$	429	W
Derate Above $25^\circ\text{C}$		2.86	W/ $^\circ\text{C}$
Operating and Storage Temperature	$T_J, T_{STG}$	-55 to +175	$^\circ\text{C}$
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	0.35	$^\circ\text{C}/\text{W}$
Maximum Thermal Resistance, Junction-to-Ambient (Note 3)	$R_{\theta JA}$	43	$^\circ\text{C}/\text{W}$

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Current is limited by bondwire configuration.
2. Starting  $T_J = 25^\circ\text{C}$ ,  $L = 0.3$  mH,  $I_{AS} = 84$  A,  $V_{DD} = 40$  V during inductor charging and  $V_{DD} = 0$  V during time in avalanche.
3.  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance, where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design, while  $R_{\theta JA}$  is determined by the board design. The maximum rating presented here is based on mounting on a 1 in<sup>2</sup> pad of 2 oz copper.

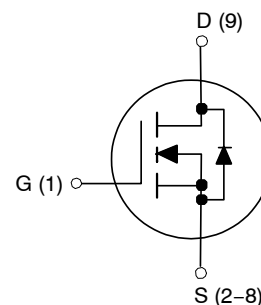


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**MO-299A  
CASE 100CU**



### ORDERING INFORMATION

Device	Package	Marking
NVBLS0D5N04M8TXG	MO-299A (Pb-Free)	0D5N04M8

# NVBLS0D5N04M8

**Table 1. ELECTRICAL CHARACTERISTICS** ( $T_J = 25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units	
<b>OFF CHARACTERISTICS</b>							
$B_{VDSS}$	Drain-to-Source Breakdown Voltage	$I_D = 250 \mu\text{A}, V_{GS} = 0 \text{ V}$	40	-	-	V	
$I_{DSS}$	Drain-to-Source Leakage Current	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}$	$T_J = 25^\circ\text{C}$	-	-	1	$\mu\text{A}$
			$T_J = 175^\circ\text{C}$ (Note 4)	-	-	1	$\text{mA}$
$I_{GSS}$	Gate-to-Source Leakage Current	$V_{GS} = \pm 20 \text{ V}$	-	-	$\pm 100$	$\text{nA}$	
<b>ON CHARACTERISTICS</b>							
$V_{GS(th)}$	Gate-to-Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu\text{A}$	2.0	3.0	4.0	V	
$R_{DS(on)}$	Drain-to-Source On Resistance	$I_D = 80 \text{ A}, V_{GS} = 10 \text{ V}$	-	0.46	0.57	$\text{m}\Omega$	
<b>DYNAMIC CHARACTERISTICS</b>							
$C_{iss}$	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	15900	-	$\text{pF}$	
$C_{oss}$	Output Capacitance		-	4000	-	$\text{pF}$	
$C_{rss}$	Reverse Transfer Capacitance		-	600	-	$\text{pF}$	
$R_g$	Gate Resistance	$f = 1 \text{ MHz}$	-	2.6	-	$\Omega$	
$Q_{g(ToT)}$	Total Gate Charge at 10 V	$V_{GS} = 0 \text{ to } 10 \text{ V}$	-	220	296	$\text{nC}$	
$Q_{g(th)}$	Threshold Gate Charge	$V_{GS} = 0 \text{ to } 2 \text{ V}$					
$Q_{gs}$	Gate-to-Source Gate Charge		-	73	-	$\text{nC}$	
$Q_{gd}$	Gate-to-Drain "Miller" Charge		-	41	-	$\text{nC}$	
<b>SWITCHING CHARACTERISTICS</b>							
$t_{on}$	Turn-On Time	$V_{DD} = 20 \text{ V}, I_D = 80 \text{ A}, V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	-	-	221	$\text{ns}$	
$t_{d(on)}$	Turn-On Delay		-	54	-	$\text{ns}$	
$t_r$	Rise Time		-	82	-	$\text{ns}$	
$t_{d(off)}$	Turn-Off Delay		-	106	-	$\text{ns}$	
$t_f$	Fall Time		-	52	-	$\text{ns}$	
$t_{off}$	Turn-Off Time		-	-	215	$\text{ns}$	
<b>DRAIN-SOURCE DIODE CHARACTERISTICS</b>							
$V_{SD}$	Source-to-Drain Diode Voltage	$I_{SD} = 80 \text{ A}, V_{GS} = 0 \text{ V}$	-	-	1.25	V	
		$I_{SD} = 40 \text{ A}, V_{GS} = 0 \text{ V}$	-	-	1.2	V	
$t_{rr}$	Reverse-Recovery Time	$I_F = 80 \text{ A}, dI_{SD}/dt = 100 \text{ A}/\mu\text{s}, V_{DD} = 32 \text{ V}$	-	119	133	$\text{ns}$	
$Q_{rr}$	Reverse-Recovery Charge		-	228	274	$\text{nC}$	

4. The maximum value is specified by design at  $T_J = 175^\circ\text{C}$ . Product is not tested to this condition in production. Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

Typical Characteristics

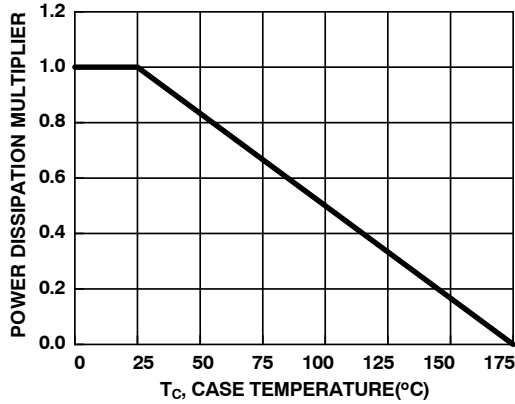


Figure 1. Normalized Power Dissipation vs. Case Temperature

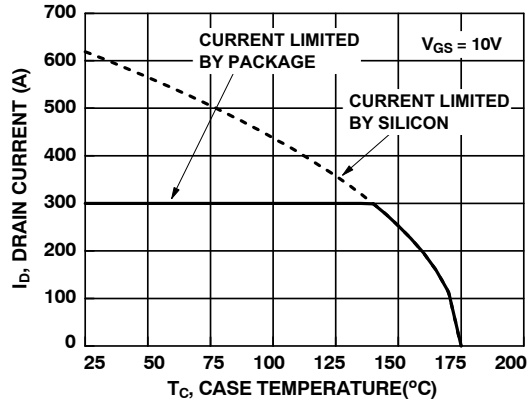


Figure 2. Maximum Continuous Drain Current vs. Case Temperature

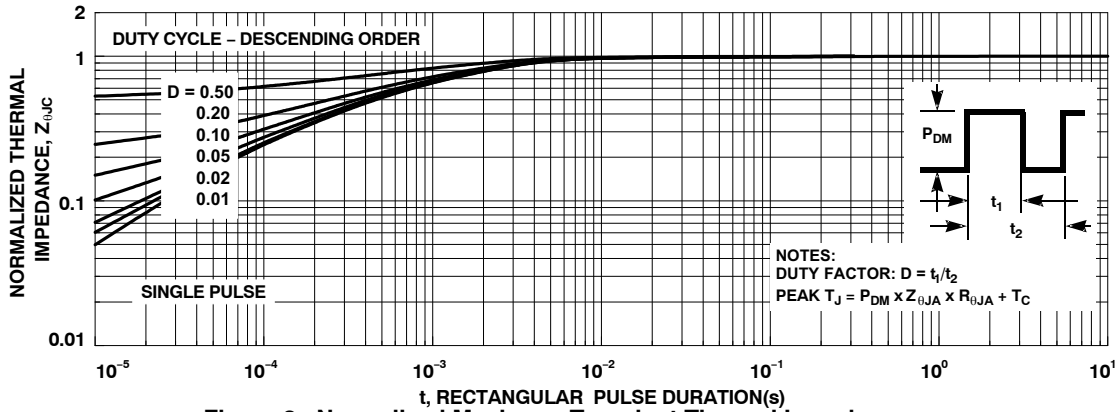


Figure 3. Normalized Maximum Transient Thermal Impedance

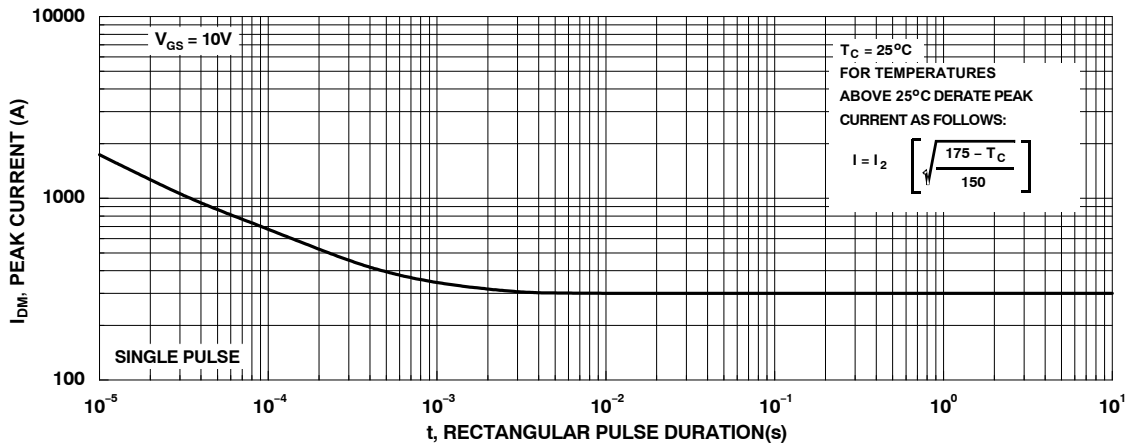


Figure 4. Peak Current Capability

Typical Characteristics

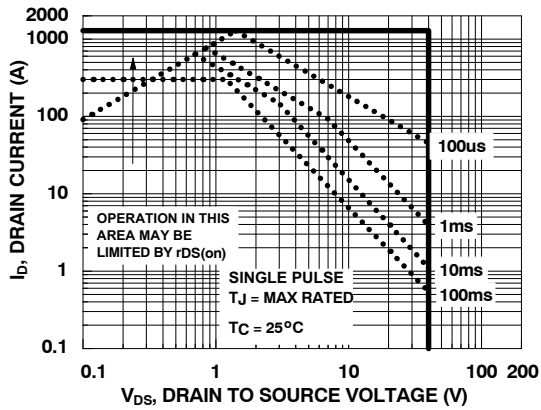
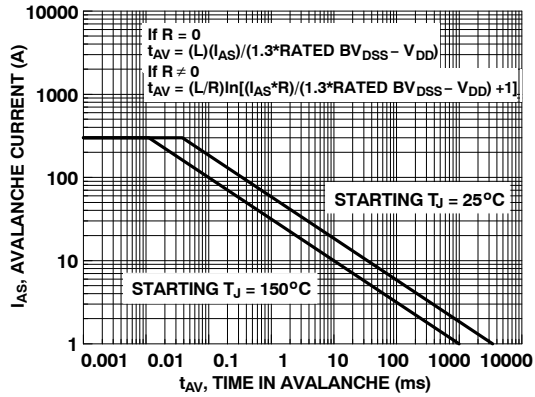


Figure 5. Forward Bias Safe Operating Area



NOTE: Refer to Fairchild Application Notes AN7514 and AN7515

Figure 6. Unclamped Inductive Switching Capability

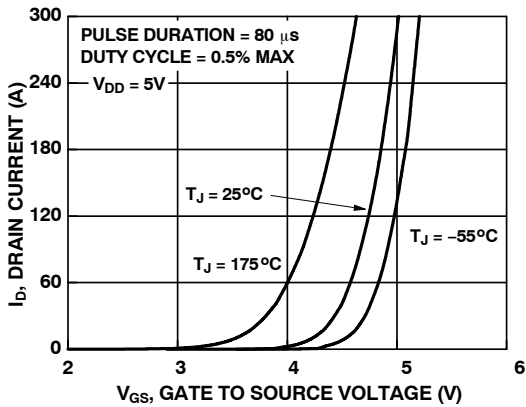


Figure 7. Transfer Characteristics

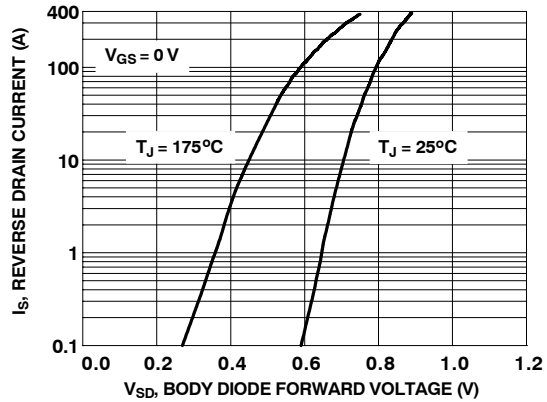


Figure 8. Forward Diode Characteristics

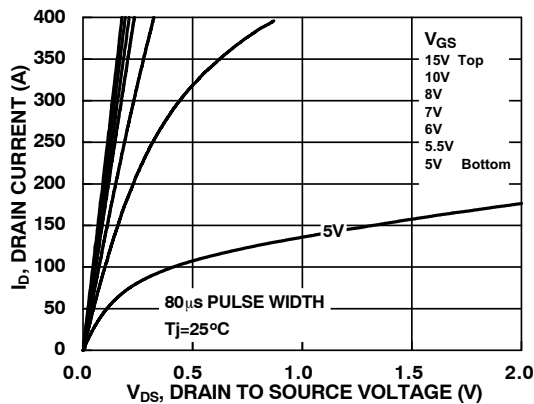


Figure 9. Saturation Characteristics

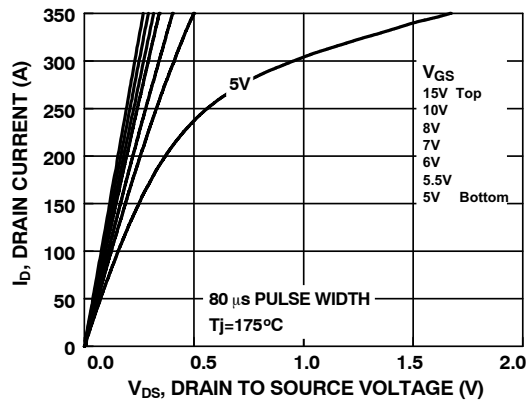


Figure 10. Saturation Characteristics

Typical Characteristics

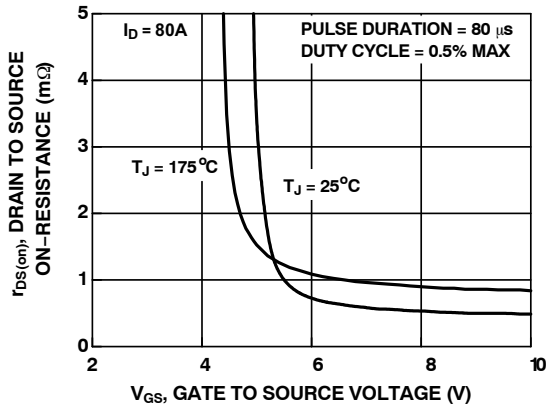


Figure 11.  $R_{DS(on)}$  vs. Gate Voltage

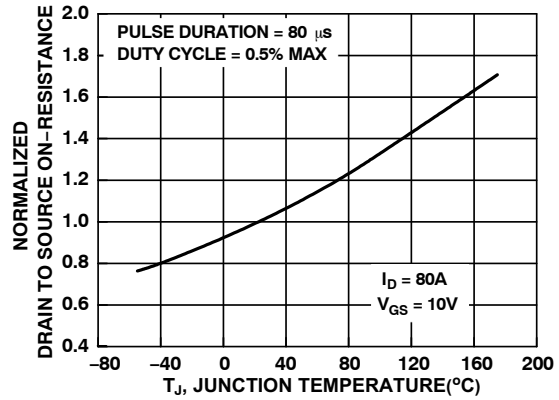


Figure 12. Normalized  $R_{DS(on)}$  vs. Junction Temperature

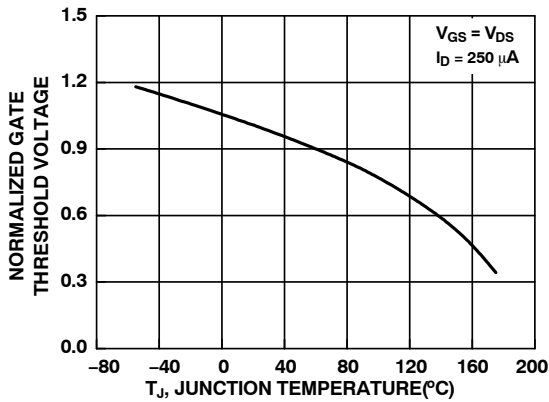


Figure 13. Normalized Gate Threshold Voltage vs. Temperature

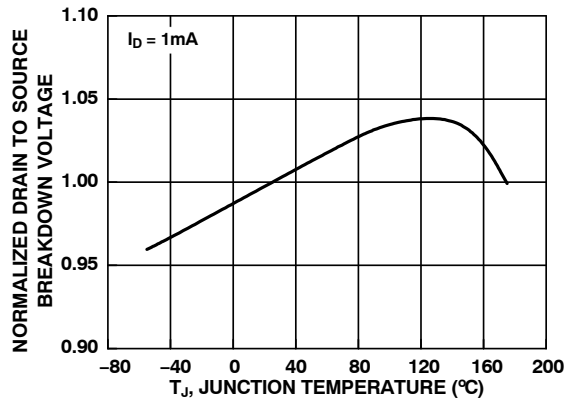


Figure 14. Normalized Drain to Source Breakdown Voltage vs. Junction Temperature

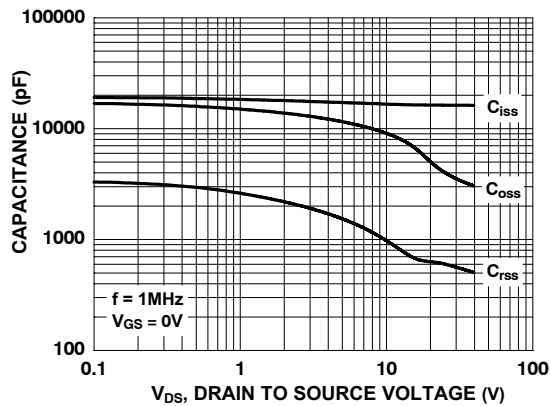


Figure 15. Capacitance vs. Drain to Source Voltage

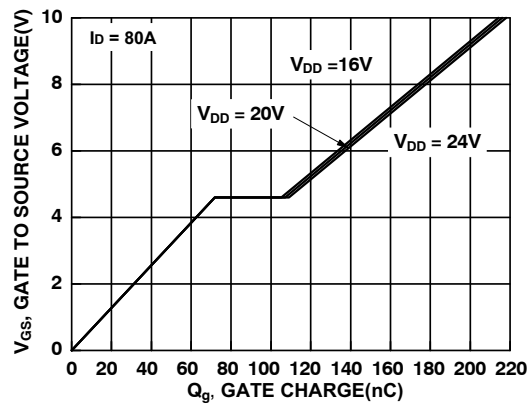


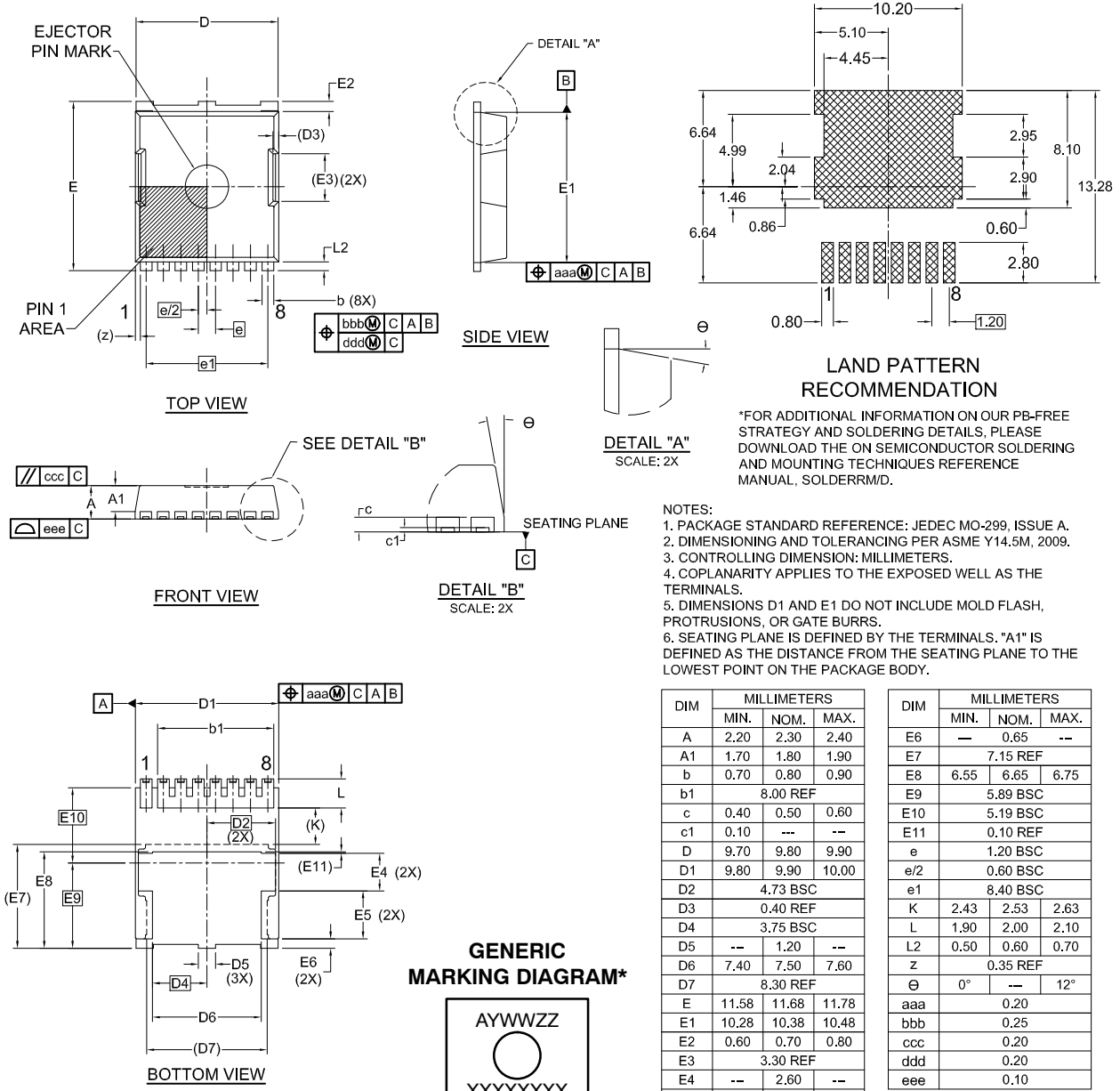
Figure 16. Gate Charge vs. Gate to Source Voltage

# MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS



## H-PSOF8L 11.68x9.80 CASE 100CU ISSUE B

DATE 20 MAY 2022

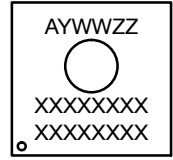


NOTES:  
 1. PACKAGE STANDARD REFERENCE: JEDEC MO-299, ISSUE A.  
 2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.  
 3. CONTROLLING DIMENSION: MILLIMETERS.  
 4. COPLANARITY APPLIES TO THE EXPOSED WELL AS THE TERMINALS.  
 5. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.  
 6. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.

DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A	2.20	2.30	2.40
A1	1.70	1.80	1.90
b	0.70	0.80	0.90
b1	8.00 REF		
c	0.40	0.50	0.60
c1	0.10	---	---
D	9.70	9.80	9.90
D1	9.80	9.90	10.00
D2	4.73 BSC		
D3	0.40 REF		
D4	3.75 BSC		
D5	---	1.20	---
D6	7.40	7.50	7.60
D7	8.30 REF		
E	11.58	11.68	11.78
E1	10.28	10.38	10.48
E2	0.60	0.70	0.80
E3	3.30 REF		
E4	---	2.60	---
E5	---	3.30	---

DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
E6	---	0.65	---
E7	7.15 REF		
E8	6.55	6.65	6.75
E9	5.89 BSC		
E10	5.19 BSC		
E11	0.10 REF		
e	1.20 BSC		
e/2	0.60 BSC		
e1	8.40 BSC		
K	2.43	2.53	2.63
L	1.90	2.00	2.10
L2	0.50	0.60	0.70
z	0.35 REF		
θ	0°	---	12°
aaa	0.20		
bbb	0.25		
ccc	0.20		
ddd	0.20		
eee	0.10		

### GENERIC MARKING DIAGRAM\*



A = Assembly Location  
 Y = Year  
 WW = Work Week  
 ZZ = Assembly Lot Code  
 XXXX = Specific Device Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "a", may or may not be present. Some products may not follow the Generic Marking.

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